



1N70

Power MOSFET

1.2 Amps, 700 Volts N-CHANNEL MOSFET

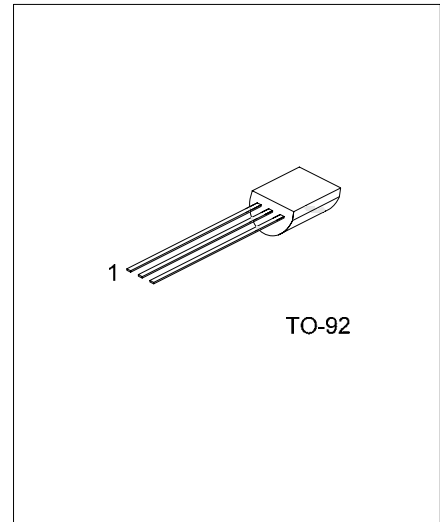
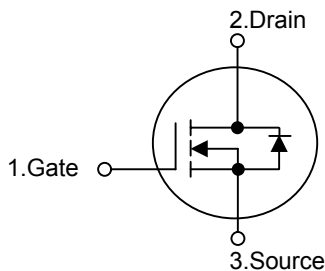
DESCRIPTION

The UTC 1N70 is a high voltage MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

FEATURES

- * $R_{DS(ON)} = 11.5\Omega @ V_{GS} = 10V$.
- * Ultra Low gate charge (typical 5.0nC)
- * Low reverse transfer capacitance ($C_{RSS} =$ typical 3.0 pF)
- * Fast switching capability
- * Avalanche energy specified
- * Improved dv/dt capability, high ruggedness

SYMBOL



*Pb-free plating product number: 1N70L

ORDERING INFORMATION

Ordering Number		Package	Pin Assignment			Packing
Normal	Lead Free Plating		1	2	3	
1N70-T92-B	1N70L-T92-B	TO-92	G	D	S	Tape Box
1N70-T92-K	1N70L-T92-K	TO-92	G	D	S	Bulk

<p>1N70L-T92-B</p> <p>(1) Packing Type (2) Package Type (3) Lead Plating</p>	<p>(1) B: Tape Box, K: Bulk, T: Tube, R: Tape Reel (2) T92: TO-92 (3) L: Lead Free Plating, Blank: Pb/Sn</p>
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■ ABSOLUTE MAXIMUM RATINGS ($T_C = 25$, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	700	V
Gate-Source Voltage		V_{GSS}	± 30	V
Avalanche Current (Note 1)		I_{AR}	1.2	A
Continuous Drain Current		I_D	1.2	A
Pulsed Drain Current (Note 1)		I_{DM}	4.8	A
Avalanche Energy	Single Pulsed (Note 2)	E_{AS}	50	mJ
	Repetitive (Note 1)	E_{AR}	4.0	mJ
Peak Diode Recovery dv/dt (Note 3)		dv/dt	4.5	V/ns
Power Dissipation		P_D	3	W
Junction Temperature		T_J	+150	
Operating Temperature		T_{OPR}	-55 ~ +150	
Storage Temperature		T_{STG}	-55 ~ +150	

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.
 Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
Junction-to-Ambient		θ_{JA}	79	/W
Junction-to-Case		θ_{JC}	29	/W

■ ELECTRICAL CHARACTERISTICS ($T_C=25$, unless otherwise specified.)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS} = 0V, I_D = 250\mu A$	700			V
Drain-Source Leakage Current	I_{DSS}	$V_{DS} = 600V, V_{GS} = 0V$			10	μA
Gate-Source Leakage Current	Forward	I_{GSS}			100	nA
	Reverse				$V_{GS} = -30V, V_{DS} = 0V$	-100
Breakdown Voltage Temperature Coefficient	BV_{DSS}/T_J	$I_D = 250\mu A$		0.4		V/
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	2.0		4.0	V
Static Drain-Source On-State Resistance	$R_{DS(ON)}$	$V_{GS} = 10V, I_D = 0.6A$		9.3	11.5	Ω
DYNAMIC CHARACTERISTICS						
Input Capacitance	C_{ISS}	$V_{DS}=25V, V_{GS}=0V, f=1MHz$		120	150	pF
Output Capacitance	C_{OSS}		20	25	pF	
Reverse Transfer Capacitance	C_{RSS}		3.0	4.0	pF	
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	$t_{D(ON)}$	$V_{DD}=300V, I_D=1.2A, R_G=50\Omega$ (Note 4,5)		5	20	ns
Turn-On Rise Time	t_R		25	60	ns	
Turn-Off Delay Time	$t_{D(OFF)}$		7	25	ns	
Turn-Off Fall Time	t_F		25	60	ns	
Total Gate Charge	Q_G	$V_{DS}=480V, V_{GS}=10V, I_D=1.2A$ (Note 4,5)		5.0	6.0	nC
Gate-Source Charge	Q_{GS}		1.0		nC	
Gate-Drain Charge	Q_{GD}		2.6		nC	
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS						
Drain-Source Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_S = 1.2A$			1.4	V
Maximum Continuous Drain-Source Diode Forward Current	I_S				1.2	A
Maximum Pulsed Drain-Source Diode Forward Current	I_{SM}				4.8	A
Reverse Recovery Time	t_{RR}	$V_{GS}=0V, I_S = 1.2A$		160		ns
Reverse Recovery Charge	Q_{RR}	$di/dt = 100A/\mu s$ (Note1)		0.3		μC

- Note:
1. Repetitive Rating: Pulse width limited by maximum junction temperature
 2. $L = 60mH, I_{AS} = 1A, V_{DD} = 50V, R_G = 25\Omega$, Starting $T_J = 25^\circ C$
 3. $I_{SD} \leq 1.2A, di/dt \leq 200A/\mu s, V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^\circ C$
 4. Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$
 5. Essentially Independent of Operating Temperature

■ TEST CIRCUITS AND WAVEFORMS

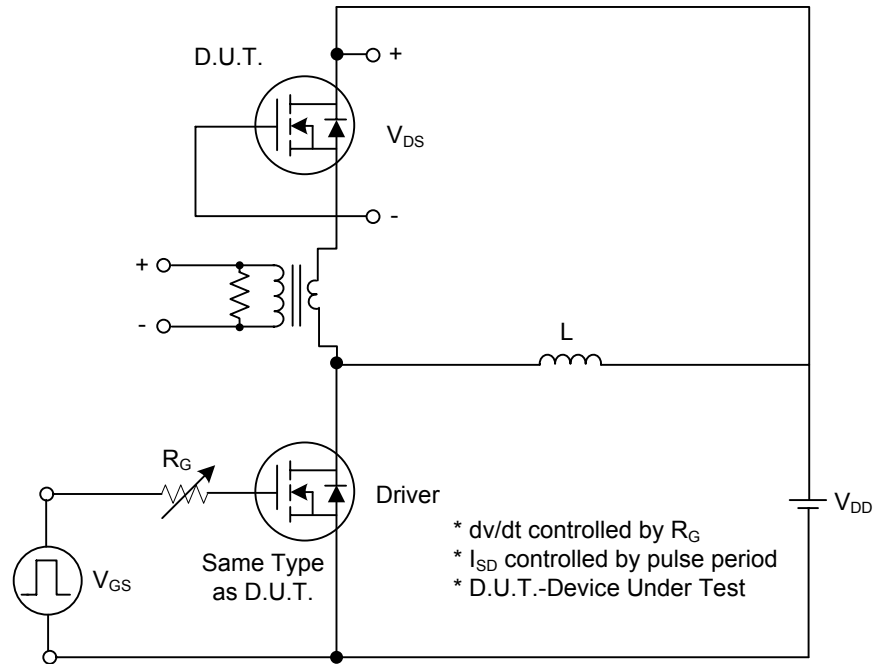


Fig. 1A Peak Diode Recovery dv/dt Test Circuit

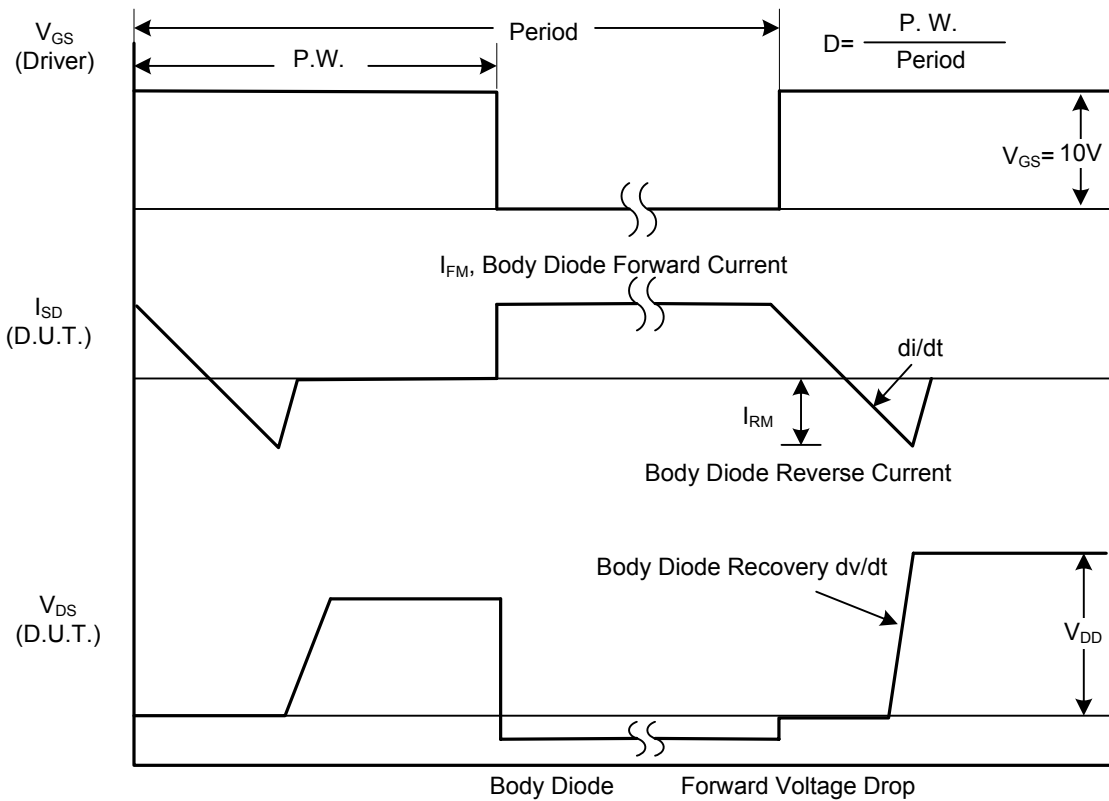


Fig. 1B Peak Diode Recovery dv/dt Waveforms

■ TEST CIRCUITS AND WAVEFORMS (Cont.)

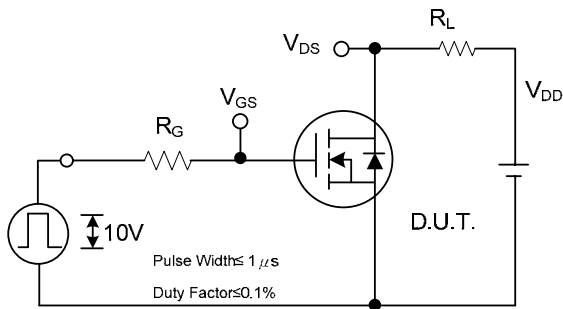


Fig. 2A Switching Test Circuit

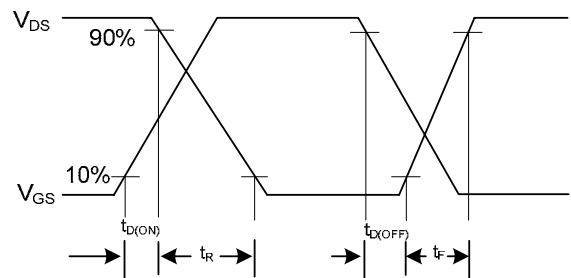


Fig. 2B Switching Waveforms

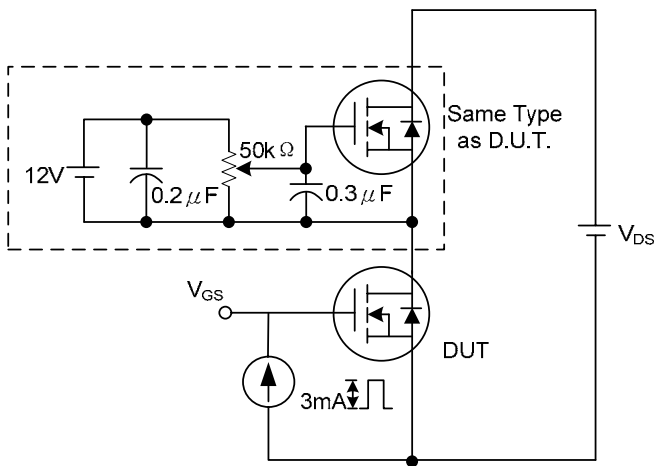


Fig. 3A Gate Charge Test Circuit

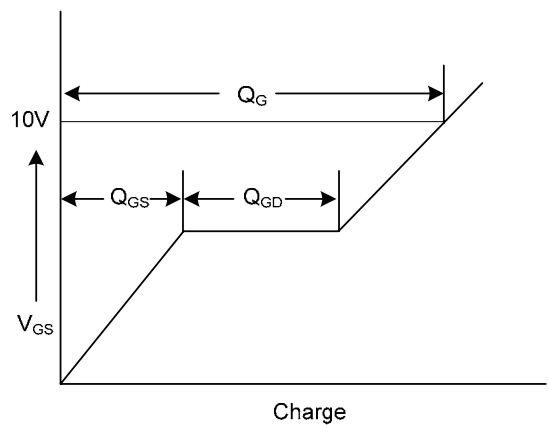


Fig. 3B Gate Charge Waveform

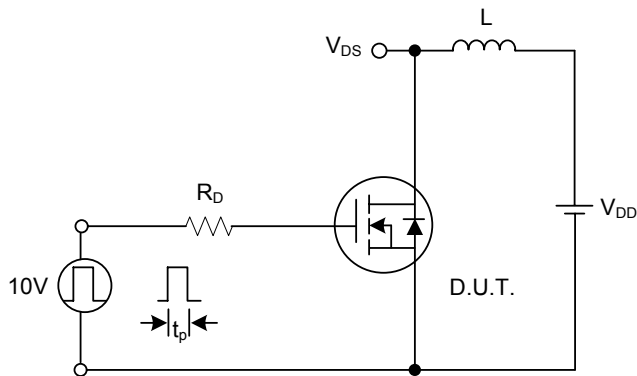


Fig. 4A Unclamped Inductive Switching Test Circuit

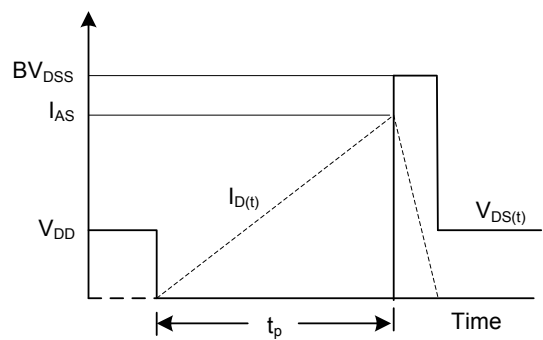
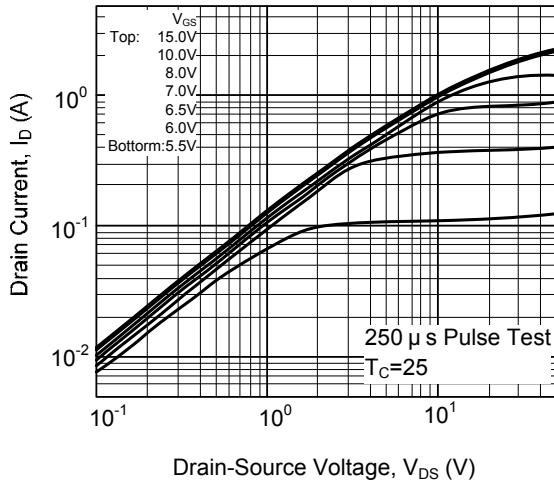


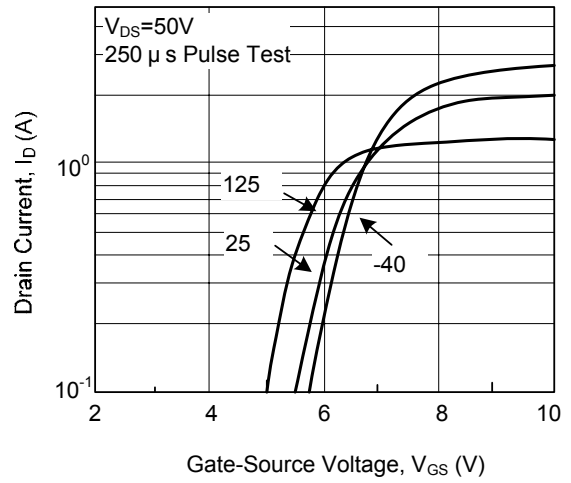
Fig. 4B Unclamped Inductive Switching Waveforms

TYPICAL CHARACTERISTICS

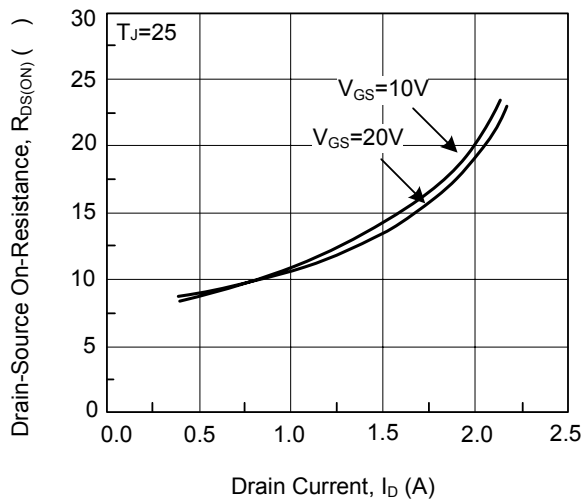
Output Characteristics



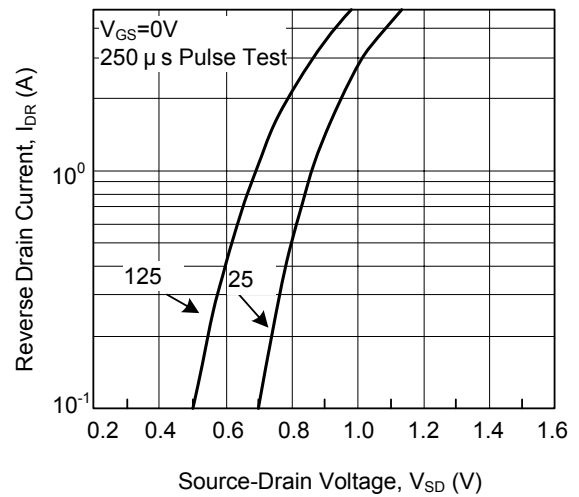
Transfer Characteristics



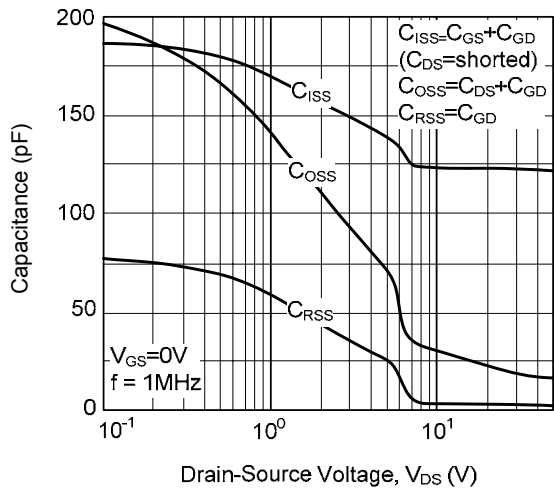
On-Resistance vs. Drain Current



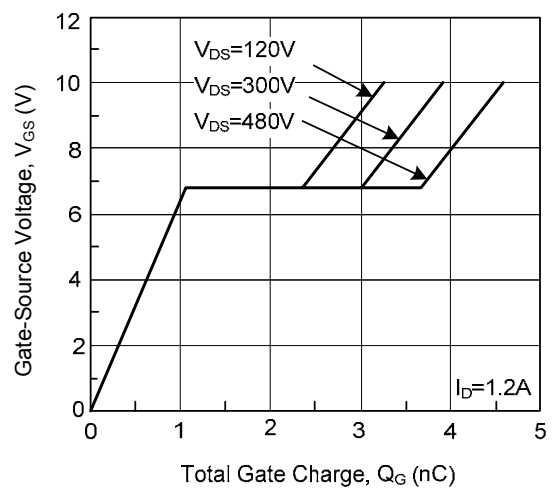
Source- Drain Diode Forward Voltage



Capacitance vs. Drain-Source Voltage

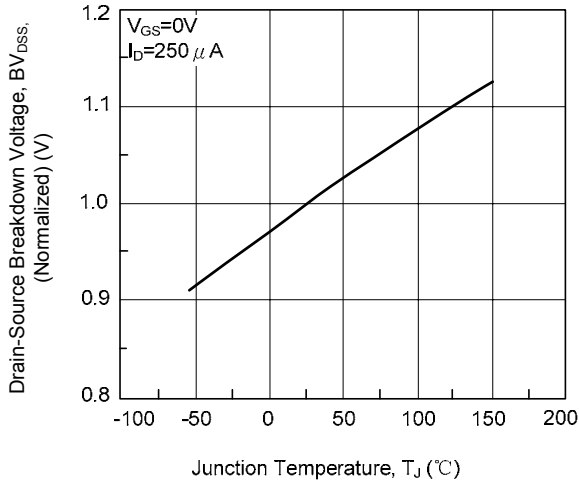


Gate Charge vs. Gate-Source Voltage

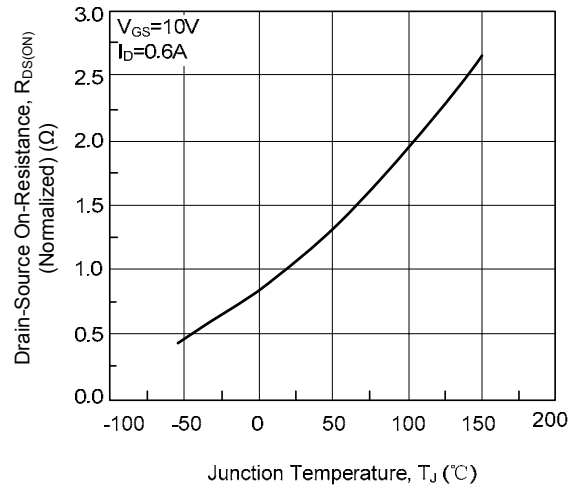


■ TYPICAL CHARACTERISTICS(Cont.)

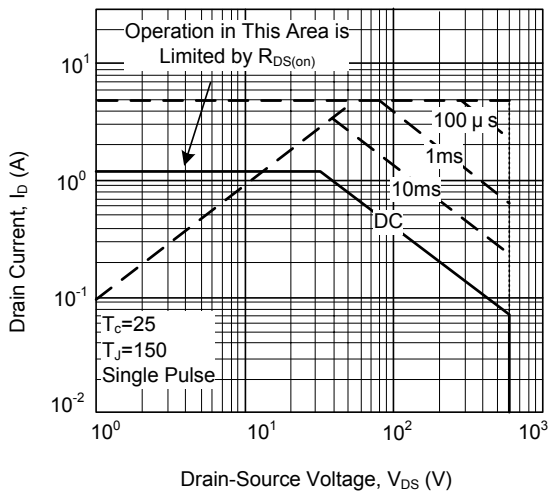
Breakdown Voltage vs. Temperature



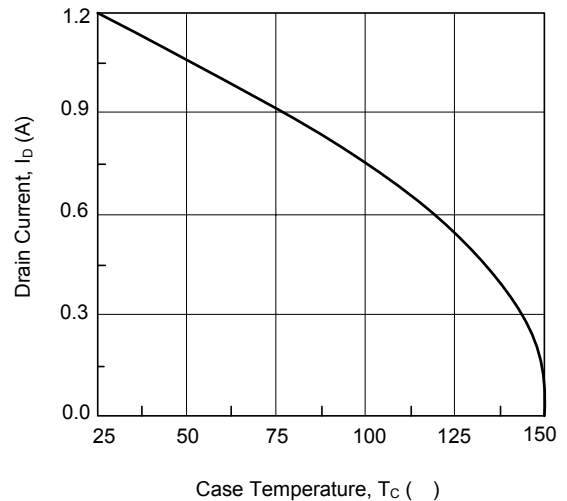
On-Resistance vs. Temperature



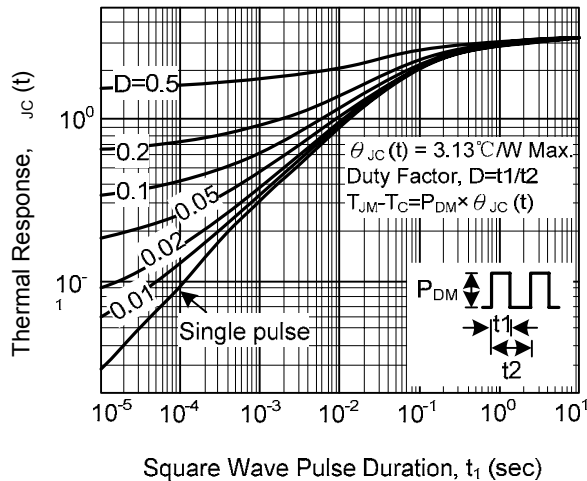
Max. Safe Operating Area



Max. Drain Current vs. Case Temperature



Thermal Response



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